



Intelligent Fault Diagnosis and Health Detection of Machinery

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Message from the Guest Editors

Modern machinery is usually characterized by a complex electromechanical or mechanical-electro-liquid system. As these systems become increasingly complex, higher standards of reliability and safety are required. To ensure the reliable operation of machines, it has always been an issue of significance to comprehensively and accurately diagnose the latent faults of the machinery. In recent years, a multitude of techniques for intelligent fault diagnosis and health detection of machinery have been developed and described in the literature. This Special Issue welcomes any original and high quality papers dealing with but are not limited to:

- (1) Early weak fault detection method of machines;
- (2) Advanced signal processing techniques for feature extraction;
- (3) Deep learning-based intelligent fault diagnosis of machines;
- (4) Fault detection of machines under varying speed conditions;
- (5) Health condition monitoring of electromechanical and mechanical-electro-liquid systems;
- (6) Reliability analysis and evaluation of electromechanical and mechanical-electro-liquid systems





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Message from the Editor-in-Chief

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